

Notice of References Cited	Application/Control No. 10/710,008	Applicant(s)/Patent Under Reexamination VON KLEECK, DAVID LAWRE	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,317,730	11-2001	Neuneier et al.	706/2
*	B	US-6,349,293	02-2002	Yamaguchi, Masashi	706/2
*	C	US-2002/0029162	03-2002	Mascarenhas, Desmond	705/10
*	D	US-2004/0054553	03-2004	Zizzamia et al.	705/001
*	E	US-6,004,267	12-1999	Tewari et al.	600/300
*	F	US-5,058,034	10-1991	Murphy et al.	706/25
*	G	US-6,470,261	10-2002	Ng et al.	706/13
*	H	US-6,272,378	08-2001	Baumgart-Schmitt, Rudolf	600/544
*	I	US-6,675,159	01-2004	Lin et al.	707/3
*	J	US-2002/0091655	07-2002	Agrafiotis et al.	706/26
*	K	US-5,809,490	09-1998	Guiver et al.	706/16
*	L	US-2002/0181784	12-2002	Shiratani, Fumiyuki	382/218
*	M	US-2001/0013026	08-2001	SHAFFER, RONALD E.	706/12

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Casalino,F and Masulli,F and Sperduti,A and Vannucci,F "Semantic Phase Transition in a classifier based on an Adaptive Fuzzy System" IEEE. 1994.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,278,799	08-2001	Hoffman, Efrem H.	706/15
*	B	US-5,479,570	12-1995	Imagawa et al.	706/20
*	C	US-2002/0062368	05-2002	Holtzman et al.	709/224
*	D	US-2002/0059154	05-2002	Rodvold, David M.	706/26
*	E	US-6,042,548	03-2000	Giuffre, Kenneth A.	600/483
*	F	US-2001/0040590	11-2001	Abbott et al.	345/700
*	G	US-5,537,590	07-1996	Amado, Armando	706/45
*	H	US-6,070,140	05-2000	Tran, Bao Q.	704/275
*	I	US-5,317,673	05-1994	Cohen et al.	704/232
*	J	US-5,970,482	10-1999	Pham et al.	706/16
*	K	US-5,832,183	11-1998	Shinohara et al.	706/20
*	L	US-5,715,821	02-1998	Faupel, Mark L.	706/20
*	M	US-6,336,109	01-2002	Howard, Gary	706/25

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0010691	01-2002	Chen, Yuan Yan	706/20
*	B	US-2002/0184171	12-2002	McClanahan, Craig J.	706/20
*	C	US-6,836,773	12-2004	Tamayo et al.	707/6
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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